# PHP30NQ15T

# N-channel TrenchMOS standard level FET

Rev. 03 — 3 March 2010

**Product data sheet** 

## 1. Product profile

## 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

### 1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Suitable for high frequency applications due to fast switching characteristics

## 1.3 Applications

■ DC-to-DC convertors

Switched-mode power supplies

### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	-	150	V
I <sub>D</sub>	drain current	$T_{mb} = 25 ^{\circ}\text{C}; V_{GS} = 10 \text{V};$ see Figure 1 and 2	-	-	29	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 3</u>	-	-	150	W
Dynamic	characteristics					
$Q_{GD}$	gate-drain charge	$V_{GS} = 10 \text{ V}; I_D = 30 \text{ A};$ $V_{DS} = 120 \text{ V}; T_j = 25 \text{ °C};$ see Figure 13	-	20	27	nC
Static ch	aracteristics					
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A};$ $T_j = 25 ^{\circ}\text{C};$ see Figure 11 and 12	-	60	63	mΩ





## 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	D
3	S	source		$G \longrightarrow A$
mb	D	mounting base; connected to drain	1 2 3	mbb076 S
			SOT78 (TO-220AB)	

## 3. Ordering information

Table 3. Ordering information

Type number Package				
	Name	Description	Version	
PHP30NQ15T	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB $$	SOT78	

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 ^{\circ}\text{C}; T_j \le 175 ^{\circ}\text{C}$	-	150	V
$V_{DGR}$	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	150	V
V <sub>GS</sub>	gate-source voltage		-20	20	V
I <sub>D</sub>	drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{A}} \text{ and } \frac{2}{\text{C}}$	-	29	Α
		V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; see <u>Figure 1</u>	-	20	Α
I <sub>DM</sub>	peak drain current	$t_p \le 10 \mu s$ ; pulsed; $T_{mb} = 25 \text{ °C}$ ; see Figure 2	-	116	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 3</u>	-	150	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-di	ain diode				
Is	source current	$T_{mb} = 25  ^{\circ}\text{C}$	-	29	Α
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	116	Α
Avalanch	ruggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 26 A; $V_{sup} \le$ 25 V; unclamped; $R_{GS}$ = 50 $\Omega$ ; $t_p$ = 0.2 ms; see Figure 4	-	502	mJ
I <sub>AS</sub>	non-repetitive avalanche current	$V_{sup} \le 25 \text{ V}; V_{GS} = 10 \text{ V}; T_{j(init)} = 25 \text{ °C};$ $R_{GS} = 50 \Omega; \text{ unclamped}; \text{ see } \frac{\text{Figure 4}}{\text{Figure 4}}$	-	29	Α

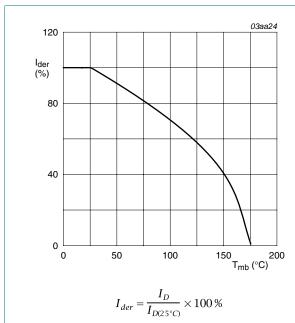
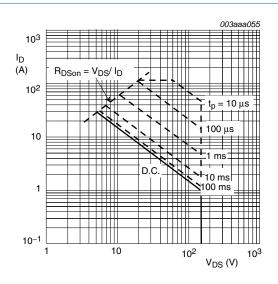


Fig 1. Normalized continuous drain current as a function of mounting base temperature



 $T_{mb} = 25$ °C;  $I_{DM}$  is single pulse

Fig 2. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

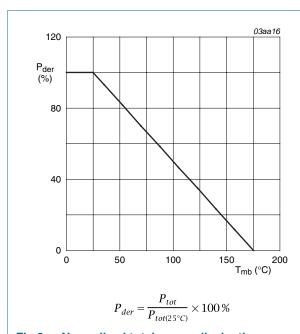
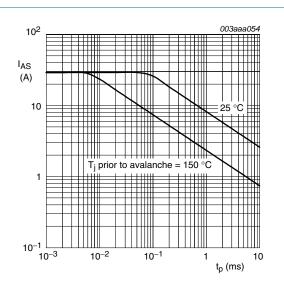


Fig 3. Normalized total power dissipation as a function of mounting base temperature



Unclamped inductive load;  $V_{DS} \le 25V$ ;  $R_{GS} = 50 \,\Omega$ ;  $V_{GS} = 10V$ ; starting at  $T_j = 25 \,^{\circ}C$  and  $150 \,^{\circ}C$ .

Fig 4. Non-repetitive avalanche ruggedness current as a function of pulse duration

## 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 5	-	-	1	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W

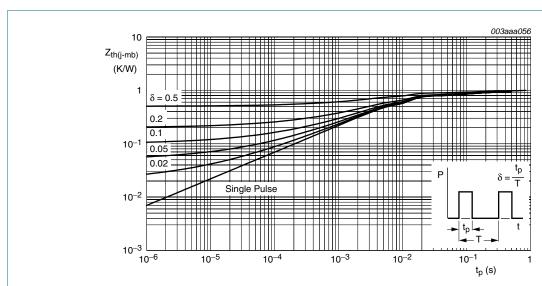


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 6. Characteristics

Table 6. Characteristics

Table 0.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 \text{ °C}$	150	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see Figure 8	2	3	4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see <u>Figure 8</u>	1	-	-	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 150 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
		$V_{DS} = 150 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	100	nA
		$V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 11 and 12	-	-	176	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 25 \text{ °C};$ see Figure 11 and 12	-	60	63	mΩ
Dynamic	characteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 30 \text{ A}; V_{DS} = 120 \text{ V}; V_{GS} = 10 \text{ V};$	-	55	-	nC
$Q_{GS}$	gate-source charge	$T_j = 25 ^{\circ}\text{C}$ ; see Figure 13	-	10	-	nC
$Q_{GD}$	gate-drain charge		-	20	27	nC
C <sub>iss</sub>	input capacitance	$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	2390	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	240	-	pF
$C_{rss}$	reverse transfer capacitance		-	98	-	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 75 V; $R_L$ = 2.7 $\Omega$ ; $V_{GS}$ = 10 V;	-	14	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 5.6 \Omega; T_j = 25 \text{ °C}$	-	50	-	ns
$t_{d(off)}$	turn-off delay time		-	48	-	ns
t <sub>f</sub>	fall time		-	38	-	ns
Source-di	rain diode					
$V_{SD}$	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 15</u>	-	0.9	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}$ ; $dI_S/dt = -100 \text{ A/}\mu\text{s}$ ; $V_{GS} = 0 \text{ V}$ ;	-	105	-	ns
$Q_r$	recovered charge	V <sub>DS</sub> = 25 V; T <sub>j</sub> = 25 °C	-	0.55	-	μC

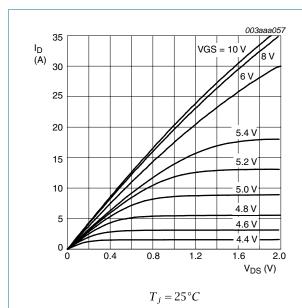
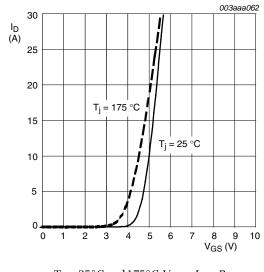


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25$ °C and 175°C; $V_{DS} > I_D \times R_{DSon}$ 

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

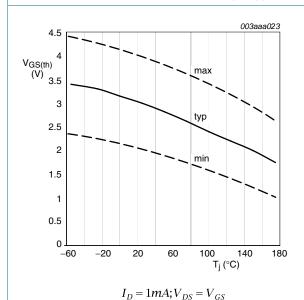
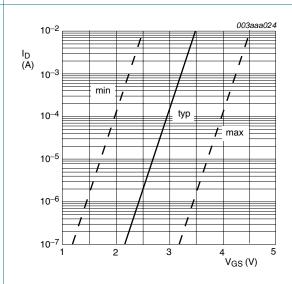
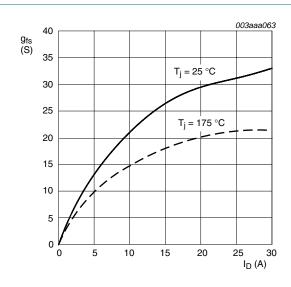


Fig 8. Gate-source threshold voltage as a function of junction temperature



 $T_i = 25^{\circ}C$ 

Fig 9. Sub-threshold drain current as a function of gate-source voltage



 $T_j = 25$ °C and 175°C;  $V_{DS} > I_D \times R_{DSon}$ 

Fig 10. Forward transconductance as a function of drain current; typical values

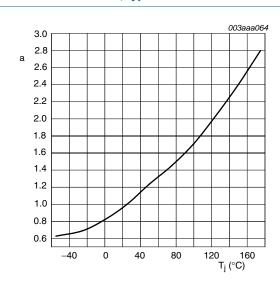
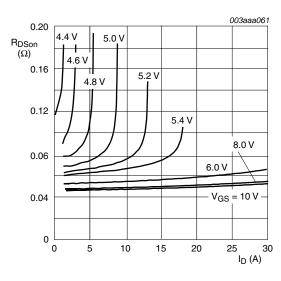
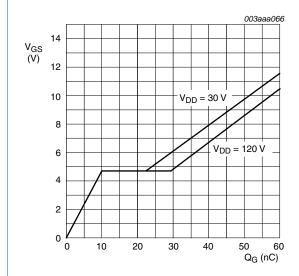


Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature



 $T_j = 25^{\circ}C$ 

Fig 11. Drain-source on-state resistance as a function of drain current; typical values



$$I_D = 30A$$
;  $V_{DS} = 30V$  and  $120V$ 

Fig 13. Gate-source voltage as a function of gate charge; typical values

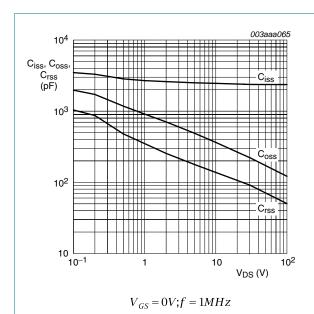


Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

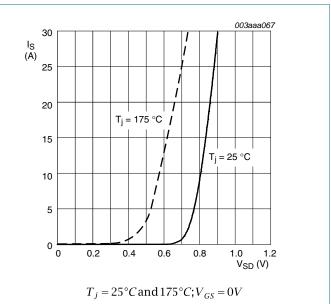
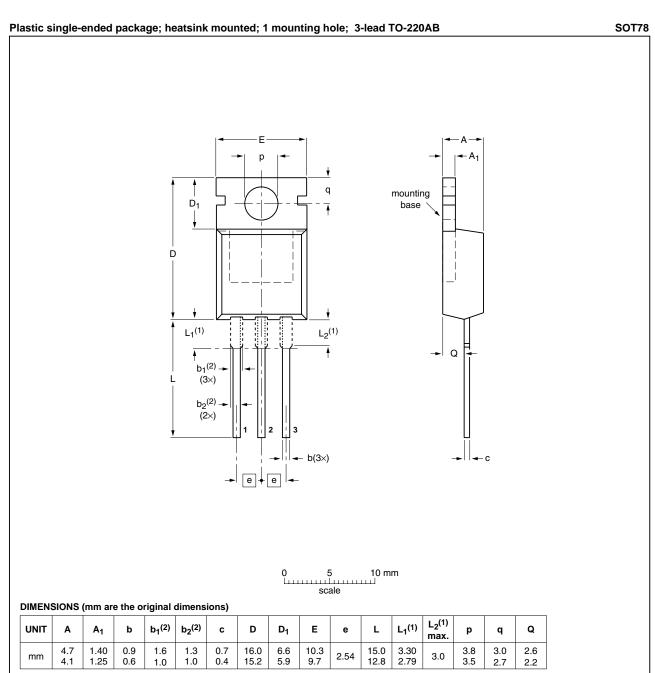


Fig 15. Source current as a function of source-drain voltage; typical values

## 7. Package outline



#### Notes

- 1. Lead shoulder designs may vary.
- 2. Dimension includes excess dambar.

OUTLINE		REFER	ENCES	EUROPEAN ISSUE D	
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT78		3-lead TO-220AB	SC-46		<del>08-04-23</del> 08-06-13

Fig 16. Package outline SOT78 (TO-220AB)

PHP30NQ15T\_3

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## **Revision history**

#### Table 7. **Revision history**

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Document ID	Release date	Data sheet status	Change notice	Supersedes
PHP30NQ15T_3	20100303	Product data sheet	-	PHB_PHP30NQ15T-02
Modifications:		of this data sheet has bee of NXP Semiconductors.	n redesigned to comply w	vith the new identity
	<ul> <li>Legal texts</li> </ul>	have been adapted to the	new company name whe	ere appropriate.
	<ul> <li>Typenumber</li> </ul>	er PHP30NQ15T separate	d from data sheet PHB_P	PHP30NQ15T-02.
PHB_PHP30NQ15T-02 (9397 750 08037)	20010312	Product specification	-	PHB_PHP30NQ15T_1
PHB_PHP30NQ15T_1	19990801	Product specification	-	-

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#### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
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## PHP30NQ15T

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